

ZXTN25100DG

100V NPN high gain transistor in SOT223

Summary

$BV_{CEX} > 180V$

$BV_{CEO} > 100V$

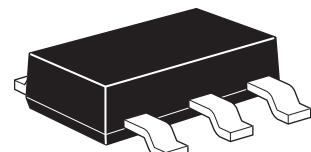
$BV_{ECO} > 6V$

$I_C(\text{cont}) = 3A$

$V_{CE(\text{sat})} < 100mV @ 1A$

$R_{CE(\text{sat})} = 85m\Omega$

$P_D = 3.0W$



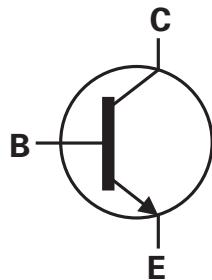
Complementary part number ZXTP19100CG

Description

Packaged in the SOT223 outline this new low saturation NPN transistor offers extremely low on state losses making it ideal for use in DC-DC circuits and various driving and power management functions.

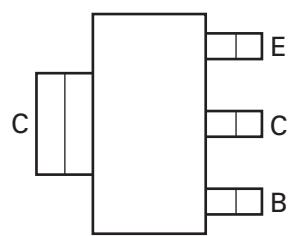
Features

- High power dissipation SOT223 package
- High gain
- Low saturation voltage
- 180V forward blocking voltage
- 6V reverse blocking voltage



Applications

- PSU start up circuit
- DC - DC converters
- Motor drive
- Relay, lamp and solenoid drive



Pinout - top view

Device	Reel size (inches)	Tape width (mm)	Quantity per reel
ZXTN25100DGTA	7	12	1000

Device marking

- ZXTN25
100D

Absolute maximum ratings

Parameter	Symbol	Limit	Unit
Collector-Base voltage	V_{CBO}	180	V
Collector-Emitter voltage (forward blocking)	V_{CEX}	180	V
Collector-Emitter voltage	V_{CEO}	100	V
Emitter-Collector voltage (reverse blocking)	V_{ECO}	6	V
Emitter-Base voltage	V_{EBO}	7	V
Continuous Collector current ^(c)	I_C	3	A
Base current	I_B	1	A
Peak pulse current	I_{CM}	3.5	A
Power dissipation at $T_A = 25^\circ\text{C}$ ^(a)	P_D	1.2	W
Linear derating factor		9.6	$\text{mW}/^\circ\text{C}$
Power dissipation at $T_A = 25^\circ\text{C}$ ^(b)	P_D	1.6	W
Linear derating factor		12.8	$\text{mW}/^\circ\text{C}$
Power dissipation at $T_A = 25^\circ\text{C}$ ^(c)	P_D	3	W
Linear derating factor		24	$\text{mW}/^\circ\text{C}$
Power dissipation at $T_A = 25^\circ\text{C}$ ^(d)	P_D	5.3	W
Linear derating factor		42	$\text{mW}/^\circ\text{C}$
Power dissipation at $T_C = 25^\circ\text{C}$ ^(e)	P_D	7.3	W
Linear derating factor		58	$\text{mW}/^\circ\text{C}$
Operating and storage temperature range	T_j, T_{stg}	-55 to 150	$^\circ\text{C}$

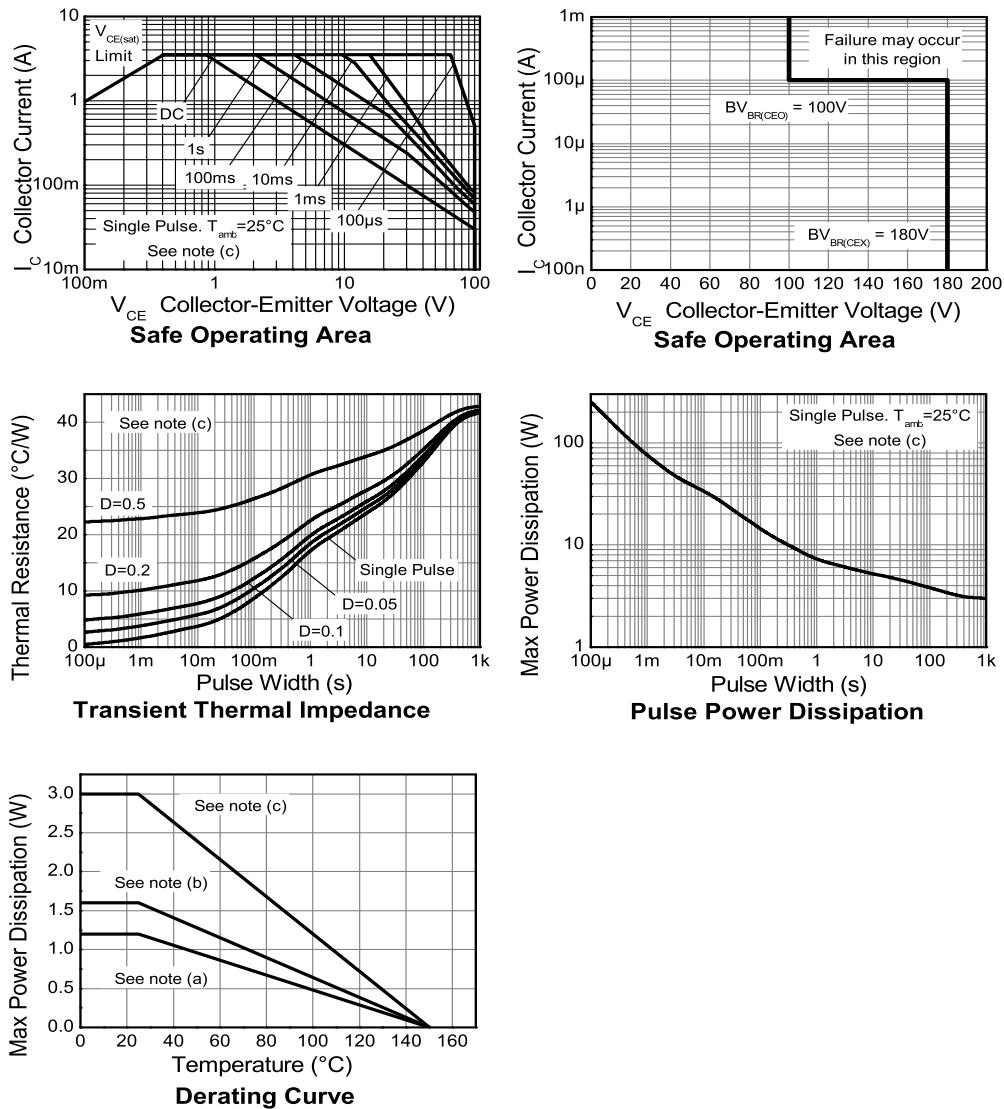
Thermal resistance

Parameter	Symbol	Limit	Unit
Junction to ambient ^(a)	$R_{\Theta JA}$	104	$^\circ\text{C}/\text{W}$
Junction to ambient ^(b)	$R_{\Theta JA}$	78	$^\circ\text{C}/\text{W}$
Junction to ambient ^(c)	$R_{\Theta JA}$	42	$^\circ\text{C}/\text{W}$
Junction to ambient ^(d)	$R_{\Theta JA}$	23.5	$^\circ\text{C}/\text{W}$
Junction to case ^(e)	$R_{\Theta JC}$	16	$^\circ\text{C}/\text{W}$

NOTES:

- (a) For a device surface mounted on 15mm x 15mm x 0.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.
- (b) Mounted on 25mm x 25mm x 0.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.
- (c) Mounted on 50mm x 50mm x 0.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions.
- (d) As (c) above measured at $t < 5$ seconds.
- (e) Junction to case (collector tab). Typical

Thermal characteristics



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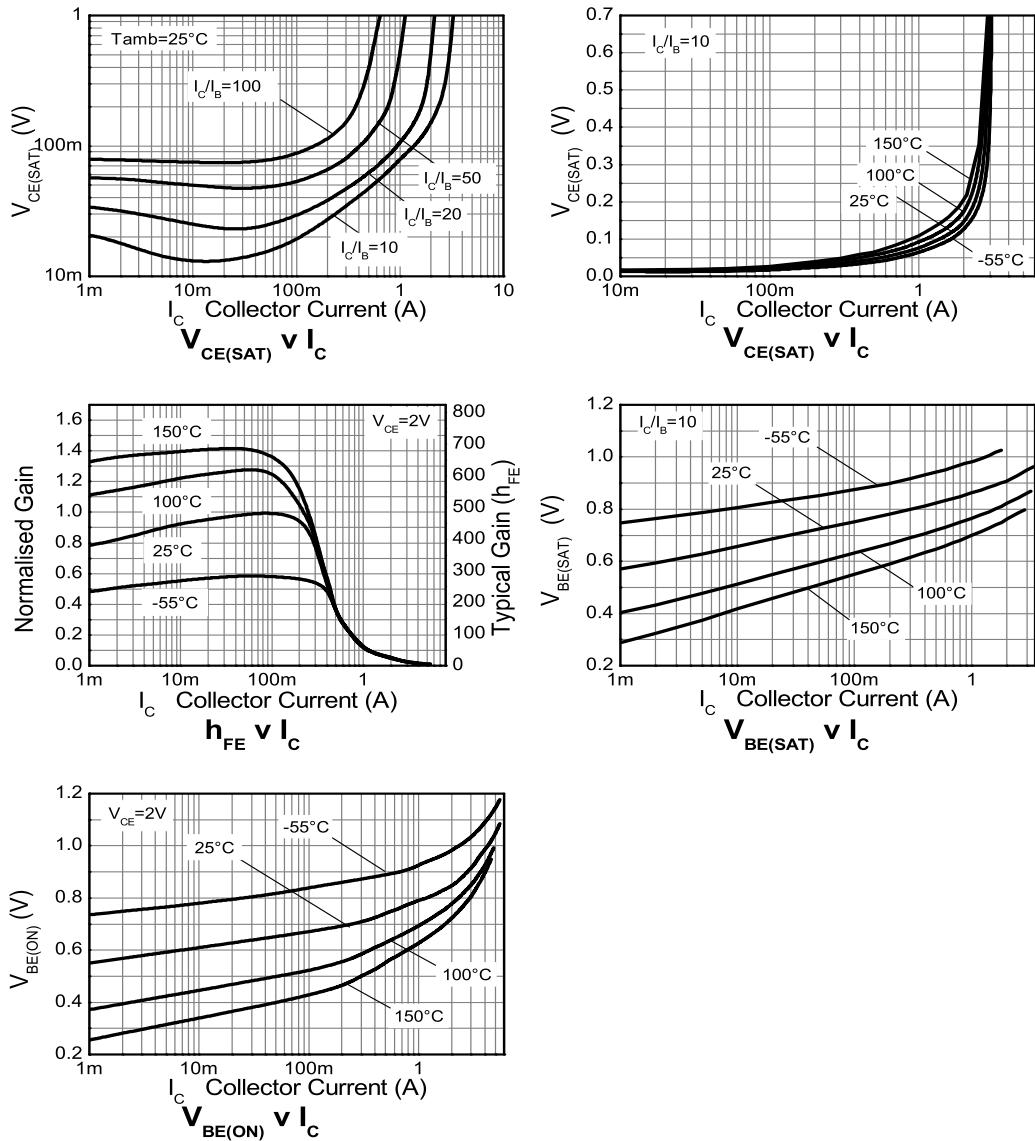
Electrical characteristics (at $T_{amb} = 25^\circ C$ unless otherwise stated)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Collector-Base breakdown voltage	BV_{CBO}	180	220		V	$I_C = 100\mu A$
Collector-Emitter breakdown voltage (forward blocking)	BV_{CEX}	180	220		V	$I_C = 100\mu A, R_{BE} < 1k\Omega$ or $-1V < V_{BC} < 0.25V$
Collector-Emitter breakdown voltage	BV_{CEO}	100	130		V	$I_C = 10mA$ (*)
Emitter-Collector breakdown voltage (reverse blocking)	BV_{ECX}	6	8.2		V	$I_E = 100\mu A, R_{BC} < 1k\Omega$ or $0.25V > V_{BC} > -0.25V$
Emitter-Collector breakdown voltage (reverse blocking)	BV_{ECO}	6	8.7		V	$I_E = 100\mu A$
Emitter-Base breakdown voltage	BV_{EBO}	7	8.3		V	$I_E = 100\mu A$
Collector-Base cut-off current	I_{CBO}		<1	50 0.5	nA μA	$V_{CB} = 180V$ $V_{CB} = 180V, T_{amb} = 100^\circ C$
Collector-Emitter cut-off current	I_{CEX}			100	nA	$V_{CE} = 100V, R_{BE} < 1k\Omega$ or $-1V < V_{BE} < 0.25V$
Emitter-Base cut-off current	I_{EBO}		<1	50	nA	$V_{EB} = 5.6V$
Collector-Emitter saturation voltage	$V_{CE(sat)}$		120 80 215 200	170 100 345 500	mV mV mV mV	$I_C = 0.5A, I_B = 10mA$ (*) $I_C = 1A, I_B = 100mA$ (*) $I_C = 2.5A, I_B = 250mA$ (*) $I_C = 3A, I_B = 600mA$ (*)
Base-Emitter saturation voltage	$V_{BE(sat)}$		1020	1100	mV	$I_C = 3A, I_B = 600mA$ (*)
Base-Emitter turn-on voltage	$V_{BE(on)}$		905	1000	mV	$I_C = 3A, V_{CE} = 2V$ (*)
Static forward current transfer ratio	h_{FE}	300 120 40	450 170 60 10	900		$I_C = 10mA, V_{CE} = 2V$ (*) $I_C = 0.5A, V_{CE} = 2V$ (*) $I_C = 1A, V_{CE} = 2V$ (*) $I_C = 3A, V_{CE} = 2V$ (*)
Transition frequency	f_T		175		MHz	$I_C = 50mA, V_{CE} = 10V$ $f = 100MHz$
Input capacitance	C_{ibo}		154	250	pF	$V_{EB} = 0.5V, f = 1MHz$ (*)
Output capacitance	C_{obo}		8.7	15	pF	$V_{CB} = 10V, f = 1MHz$ (*)
Delay time	t_d		16.4		ns	$I_C = 500mA, V_{CC} = 10V$, $I_{B1} = -I_{B2} = 50mA$
Rise time	t_r		115		ns	
Storage time	t_s		763		ns	
Fall time	t_f		158		ns	

NOTES:

(*) Measured under pulsed conditions. Pulse width $\leq 300\mu s$; duty cycle $\leq 2\%$.

Typical characteristics

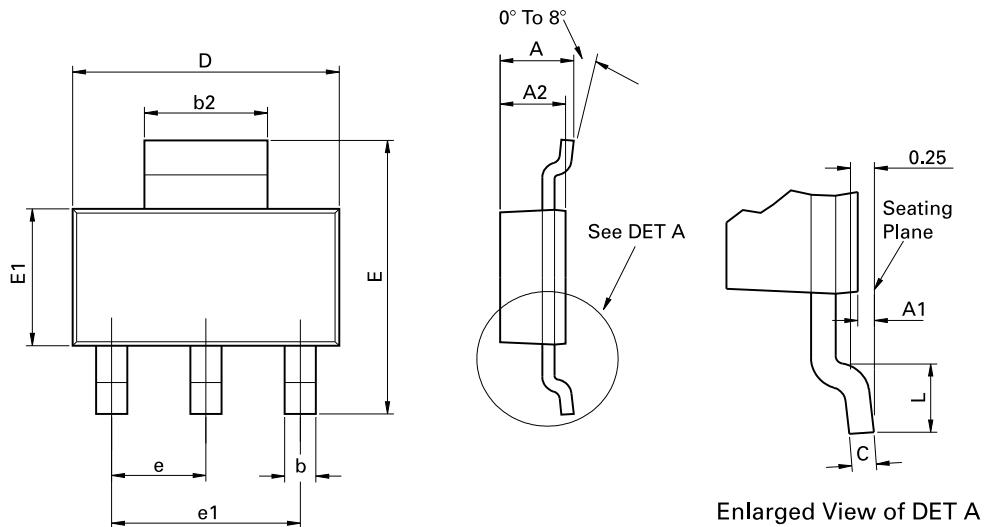


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Package outline - SOT223



Enlarged View of DET A

Conforms to JEDEC TO-261 AA Issue B

Dim.	Millimeters		Inches		Dim.	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	-	1.80	-	0.071	D	6.30	6.70	0.248	0.264
A1	0.02	0.10	0.0008	0.004	e	2.30 BSC		0.0905 BSC	
A2	1.55	1.65	0.0610	0.0649	e1	4.60 BSC		0.181 BSC	
b	0.66	0.84	0.026	0.033	E	6.70	7.30	0.264	0.287
b2	2.90	3.10	0.114	0.122	E1	3.30	3.70	0.130	0.146
C	0.23	0.33	0.009	0.013	L	0.90	-	0.355	-

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches

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